



美浦森半导体
M semitek



SLB3205T/SLP3205T

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60V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

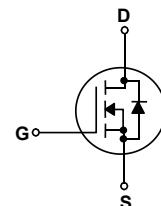
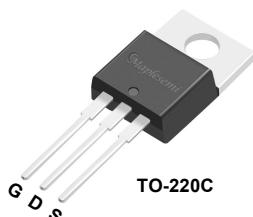
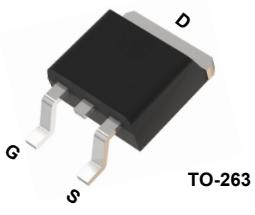
This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

- PWM Application
- Load Switch
- Power Management

Features

- N-Channel: 60V 120A
- $R_{DS(on)Typ} = 4.9m\Omega @ V_{GS} = 10 V$
- Very Low On-resistance $R_{DS(ON)}$
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_C = 25^\circ C$ unless otherwise noted

Symbol	Parameter	SLB3205T/SLP3205T	Units
V_{DSS}	Drain-Source Voltage	60	V
I_D	Drain Current - Continuous ($T_C = 25^\circ C$) - Continuous ($T_C = 100^\circ C$)	120 90	A
I_{DM}	Drain Current - Pulsed	(Note 1) 380	A
V_{GSS}	Gate-Source Voltage	± 25	V
E_{AS}	Single Pulsed Avalanche Energy	(Note 2) 625	mJ
P_D	Power Dissipation ($T_C = 25^\circ C$)	150	W
	Power Dissipation ($T_C = 100^\circ C$)	75	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to ambient	-	$^\circ C/W$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ C$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ C$

* Drain current limited by maximum junction temperature.

Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLB3205T	SLB3205T	TO-263	Tape & Reel	800	4000
SLP3205T	SLP3205T	TO-220C	Tube	1000	5000

Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 60 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1.0	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	2	3	4	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 40 \text{ A}$	--	4.9	6.5	$\text{m}\Omega$
R_G	Gate Resistance	$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = 0 \text{ V}, f = 1 \text{ MHz}$	--	1.3	-	Ω

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = 30 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	3000	-	pF
C_{oss}	Output Capacitance		--	430	-	pF
C_{rss}	Reverse Transfer Capacitance		--	240	-	pF

Switching Characteristics

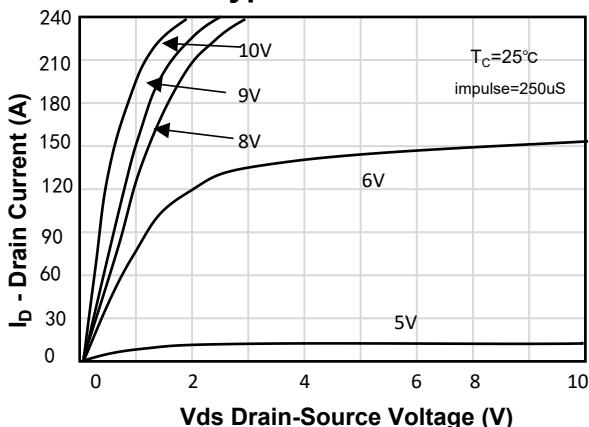
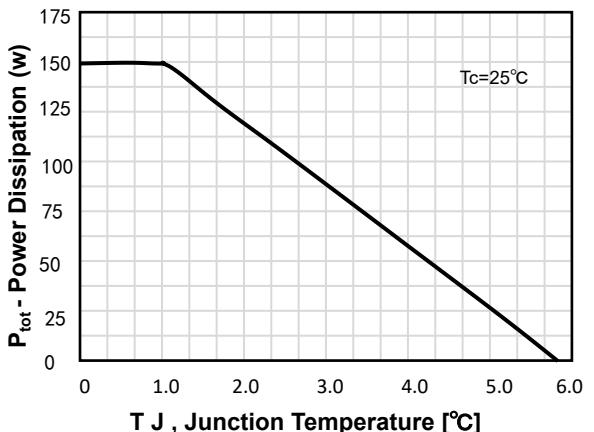
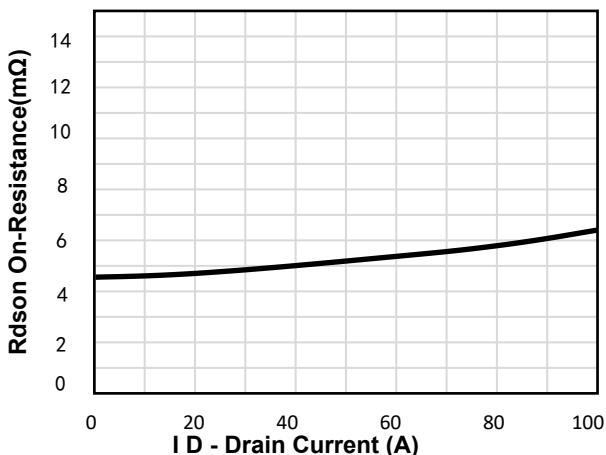
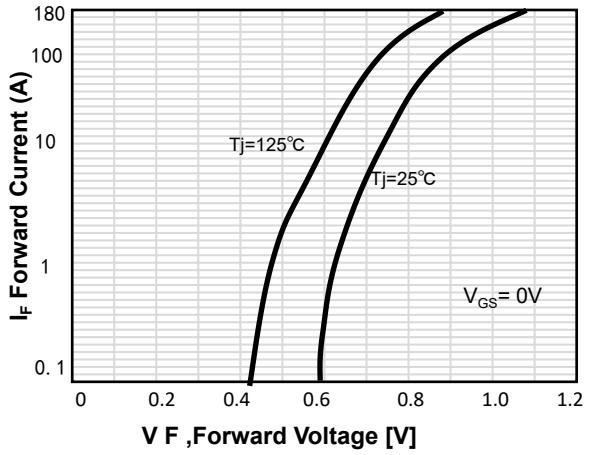
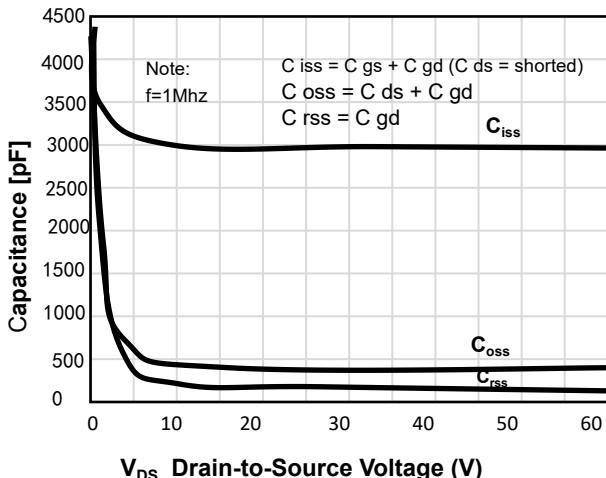
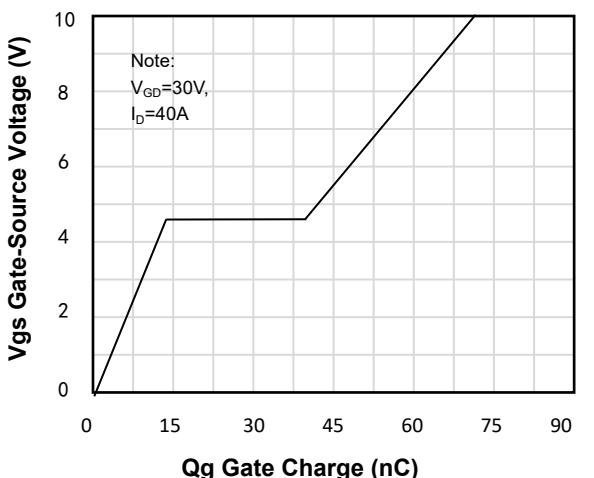
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}} = 10 \text{ V}, V_{\text{DS}} = 30 \text{ V}, R_G = 4.5 \Omega, I_D = 40 \text{ A}$	--	14	--	ns
t_r	Turn-On Rise Time		--	17	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	40	--	ns
t_f	Turn-Off Fall Time		--	62	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 30 \text{ V}, I_D = 40 \text{ A}, V_{\text{GS}} = 10 \text{ V}$	--	72	--	nC
Q_{gs}	Gate-Source Charge		--	13	--	nC
Q_{gd}	Gate-Drain Charge		--	24	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

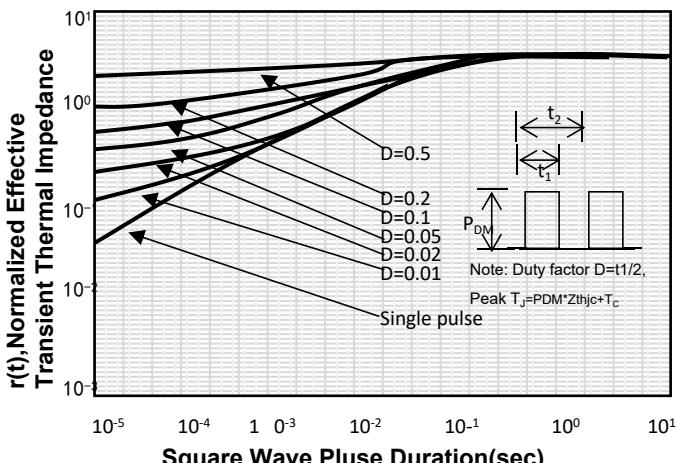
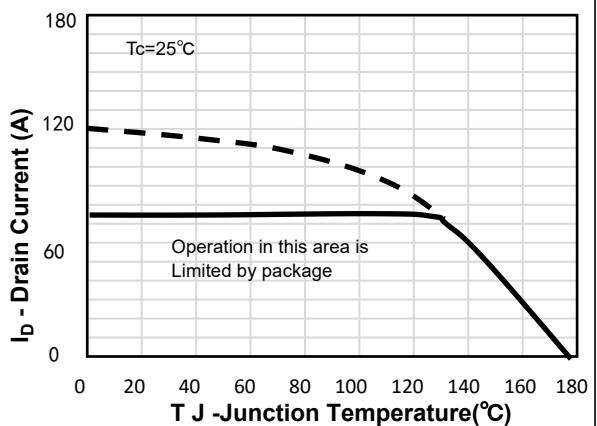
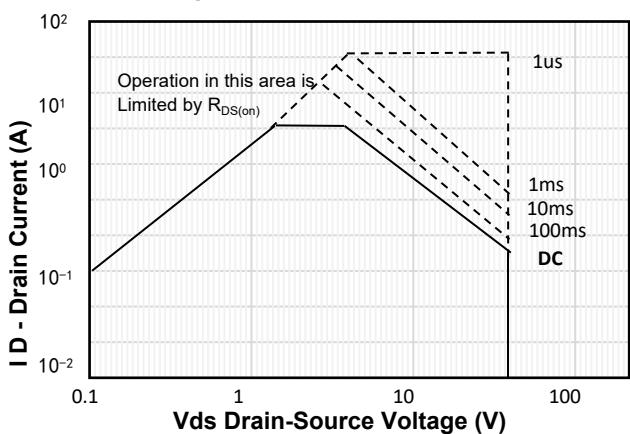
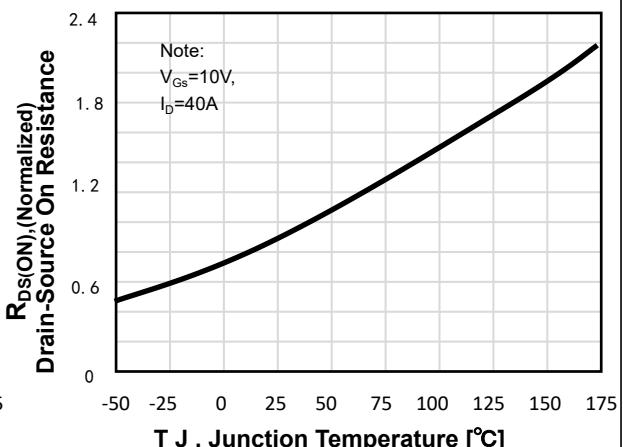
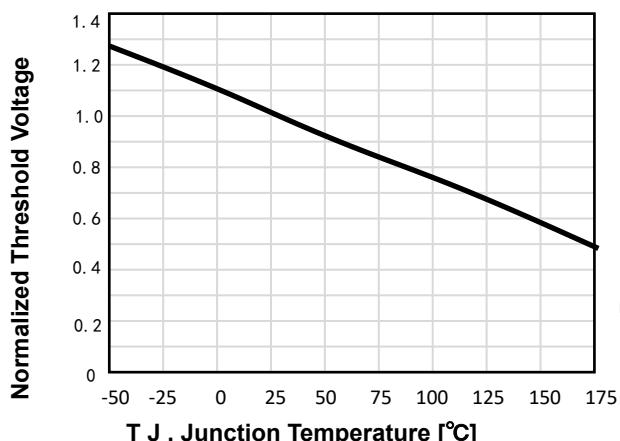
I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	120	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	480	A
V_{SD}	Drain to Source Diode Forward Voltage, $V_{\text{GS}} = 0 \text{ V}, I_{\text{SD}} = 40 \text{ A}, T_J = 25^\circ\text{C}$	--	-	1.2	V
T_{rr}	Reverse recovery time, $I_{\text{SD}} = 40 \text{ A}$ $dI_{\text{SD}}/dt = 100 \text{ A}/\mu\text{s}$		50		ns
Q_{rr}	Reverse recovery charge, $I_{\text{SD}} = 40 \text{ A}$ $dI_{\text{SD}}/dt = 100 \text{ A}/\mu\text{s}$		95		nC

Notes:

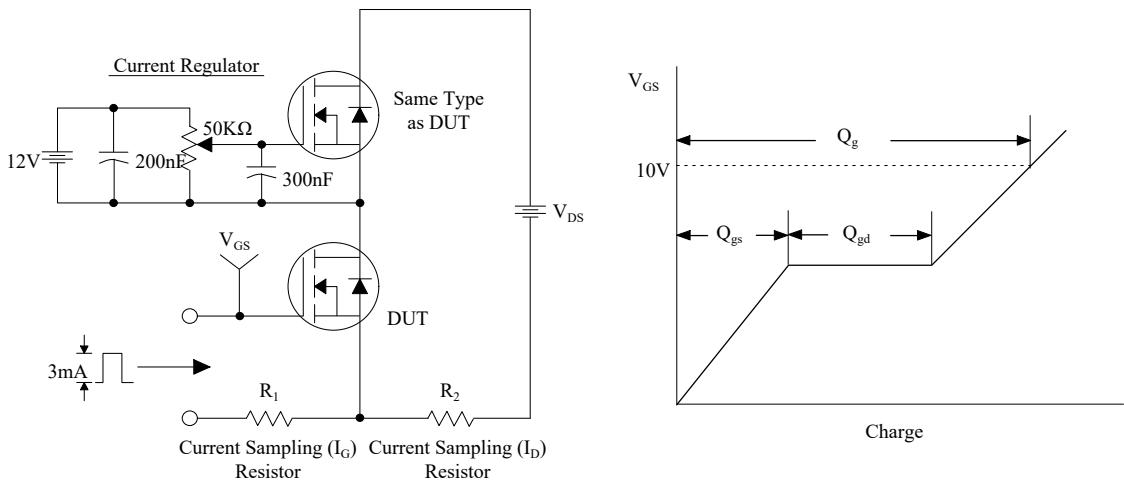
- Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- EAS condition: $T_J = 25^\circ\text{C}$, $V_{\text{DD}} = 48 \text{ V}$, $V_G = 10 \text{ V}$, $L = 0.5 \text{ mH}$, $I_{\text{AS}} = 27 \text{ A}$
- Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 0.5\%$

N- Channel Typical Characteristics**Figure 1. On-Region Characteristics****Figure 2. Power Dissipation vs Temperature****Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage****Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature****Figure 5. Capacitance Characteristics****Figure 6. Gate Charge Characteristics**

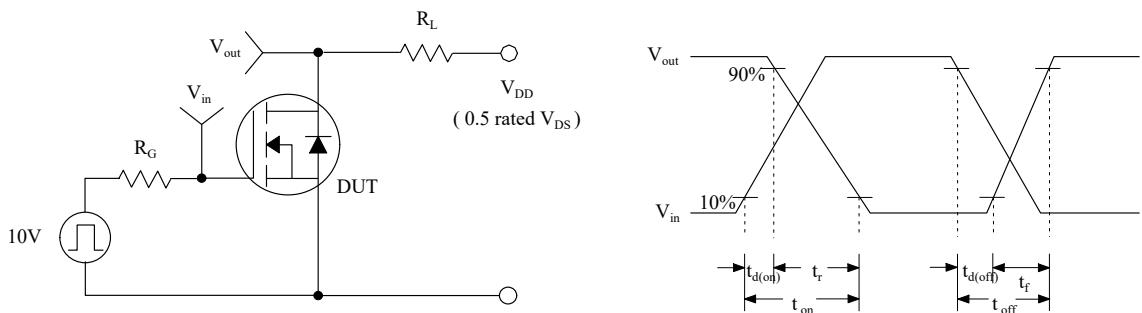
N-Channel Typical Characteristics (Continued)



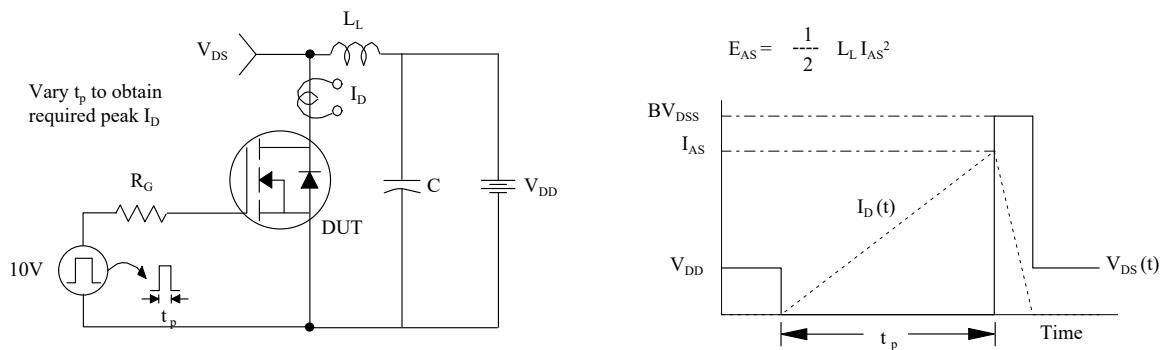
Gate Charge Test Circuit & Waveform



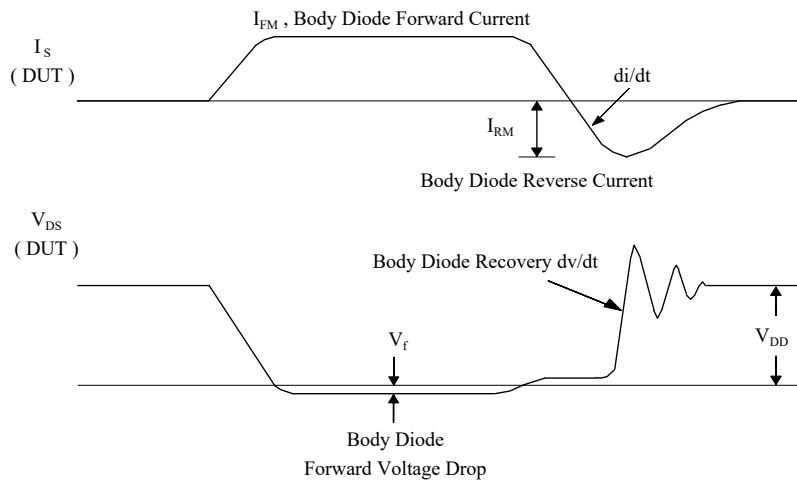
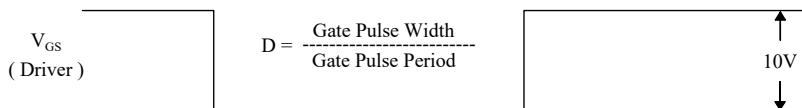
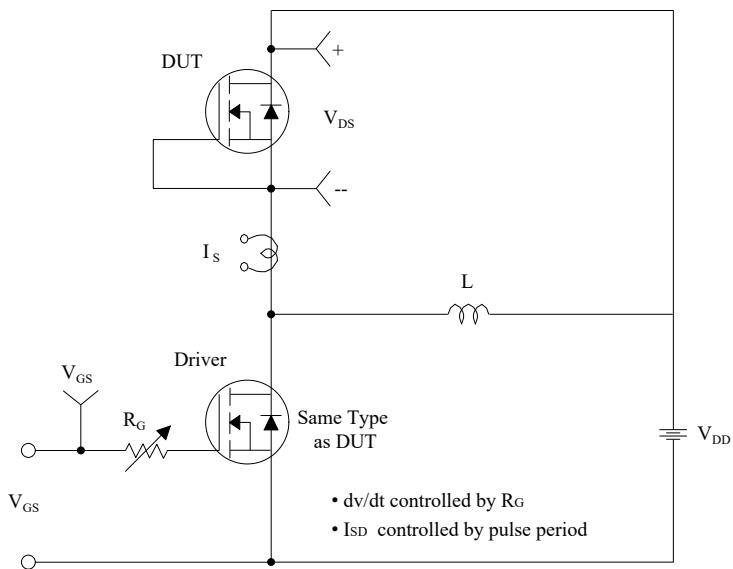
Resistive Switching Test Circuit & Waveforms



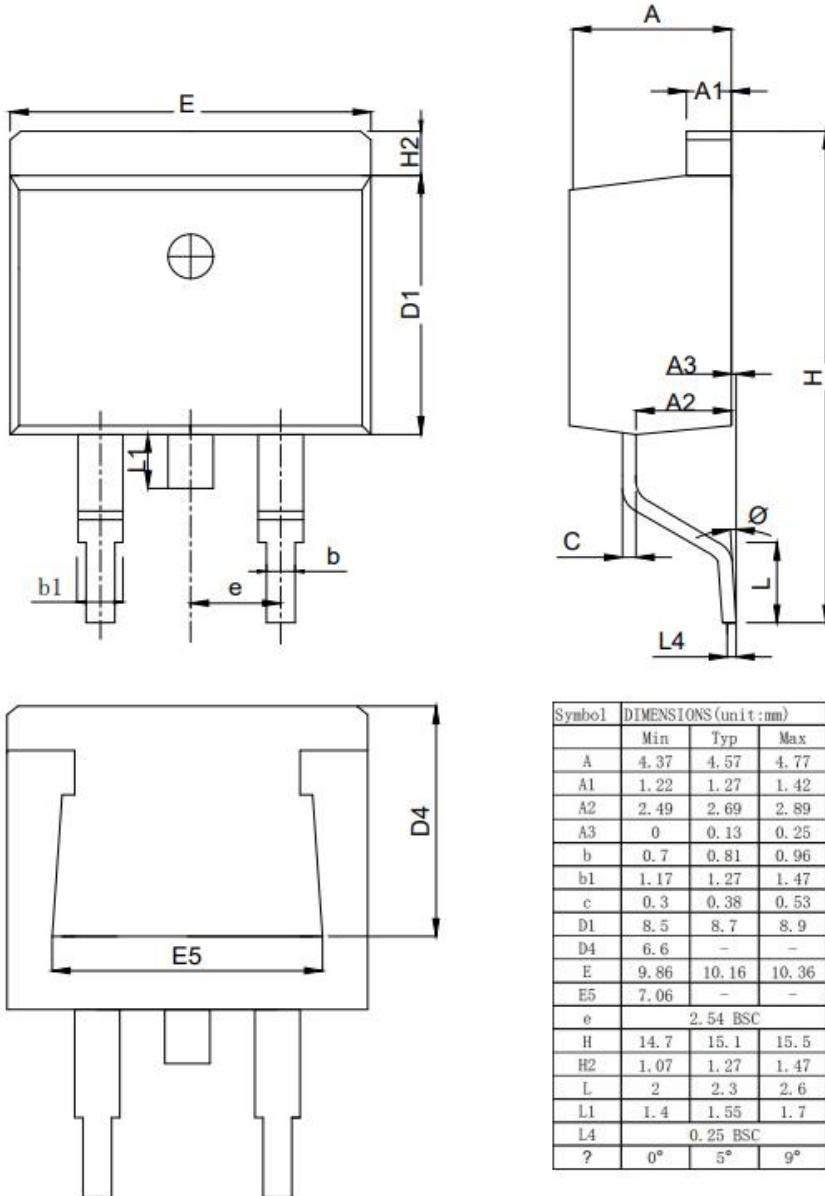
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms



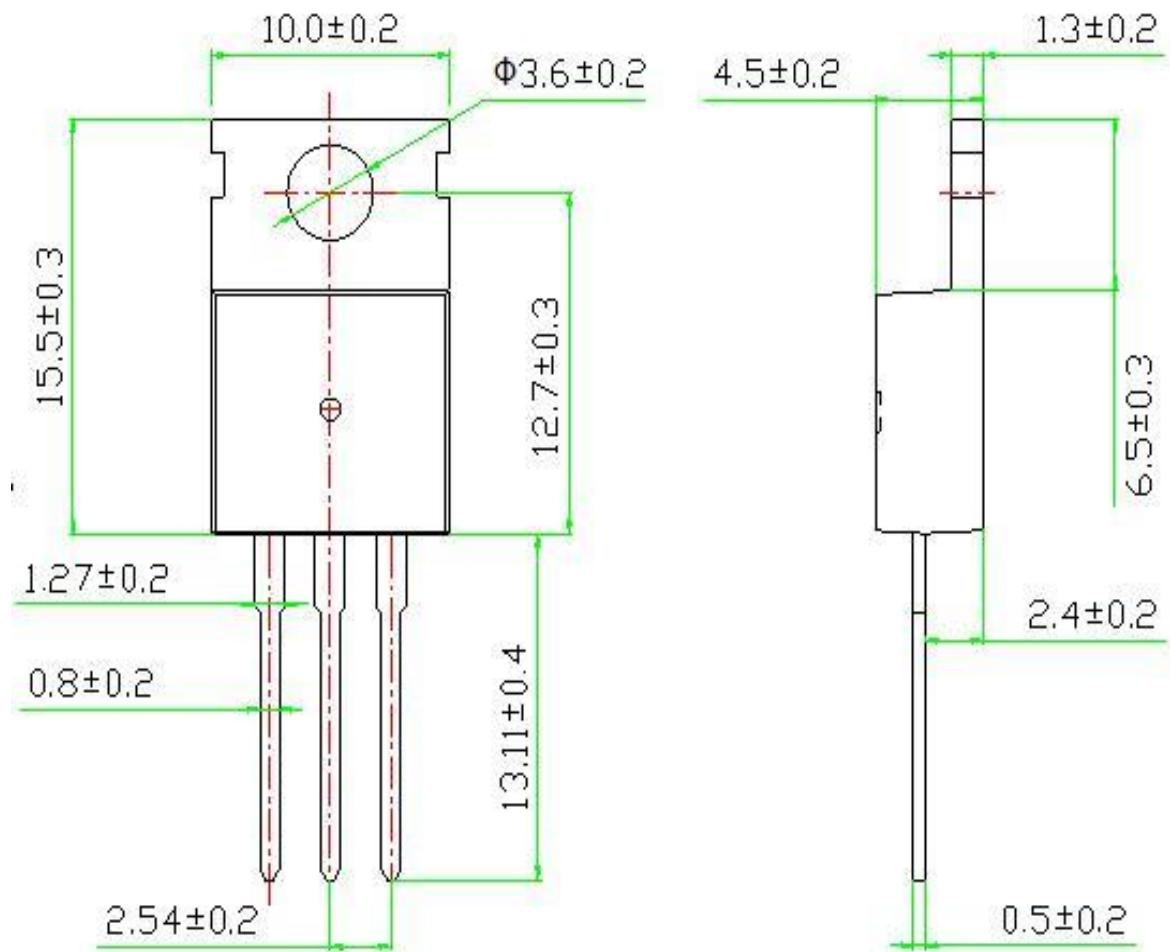
TO-263 OUTLINE



NOTE:

- 1.The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2.Undeclared tolerance±0.25,Unmarked filletRmax=0.25

TO-220C OUTLINE



NOTE:

- 1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2.Undeclared tolerance ± 0.25 ,Unmarked filletRmax=0.25

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